

TOSHIBA Bipolar Digital Integrated Circuit Silicon Monolithic

TD62308APG, TD62308AFG

4ch Low Input Active High-Current Darlington Sink Driver

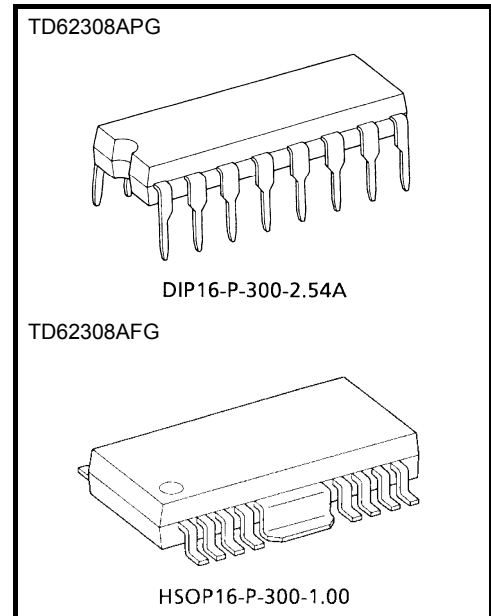
The TD62308APG/AFG is a non-inverting transistor array which is comprised of four NPN darlington output stages and PNP input stages.

This device is low-level input active driver and is suitable for operation with 5-V TTL, 5-V CMOS and 5-V Microprocessor which have sink current output drivers.

Application include relay, hammer, lamp and stepping motor drivers.

Features

- Output current (single output): 1.5 A (max)
- High sustaining voltage output: 50 V (min)
- Output clamp diodes
- Input compatible with TTL and 5 V CMOS
- Low level active inputs
- Standard supply voltage
- Two VCC terminals VCC1, VCC2 (separated)
- GND and SUB terminal = Heat sink
- Package type-APG: DIP-16 pin
- Package type-AFG: HSOP-16 pin



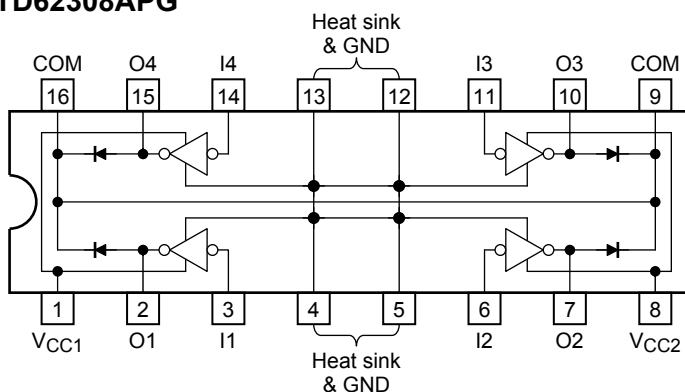
Weight

DIP16-P-300-2.54A: 1.11 g (typ.)

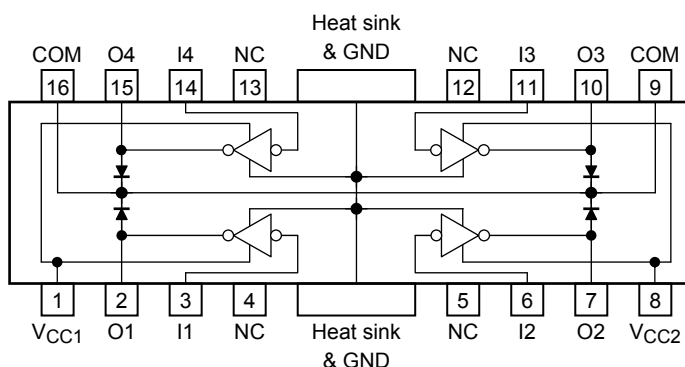
HSOP16-P-300-1.00: 0.50 g (typ.)

Pin Assignment (top view)

TD62308APG



TD62308AFG



2011-02-23

Recommended Operating Conditions ($T_a = -40$ to 85°C)

Characteristics		Symbol	Test Condition		Min	Typ.	Max	Unit
Supply voltage		V _{CC}	—		4.5	—	5.5	V
Output sustaining voltage		V _{CE (SUS)}	—		0	—	50	V
Output current	APG	I _{OUT}	DC1 circuit, Ta = 25°C		0	—	1250	mA/ch
			t _{pw} = 25 ms 4 circuits Ta = 85°C Tj = 120°C	Duty = 10%	0	—	1250	
				Duty = 50%	0	—	700	
				Duty = 10%	0	—	1250	
				Duty = 50%	0	—	390	
Input voltage	Output ON	V _{IN}	—		0	—	25	V
		V _{IN (ON)}	—		0	—	V _{CC} -3.6	V
		V _{IN (OFF)}	—		V _{CC} -1.0	—	V _{CC}	
Clamp diode reverse voltage		V _R	—		—	—	50	V
Clamp diode forward current		I _F	—		—	—	1.25	A
Power dissipation	APG	P _D	Ta = 85°C (Note 1)		—	—	1.4	W
	AFG		Ta = 85°C (Note 2)		—	—	0.7	

 Note 1: On glass epoxy PCB ($50 \times 50 \times 1.6\text{ mm Cu } 50\%$)

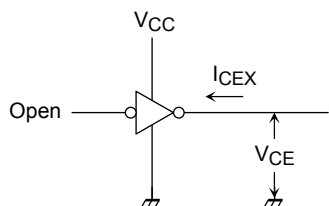
 Note 2: On glass epoxy PCB ($60 \times 30 \times 1.6\text{ mm Cu } 30\%$)

Electrical Characteristics ($T_a = 25^\circ\text{C}$)

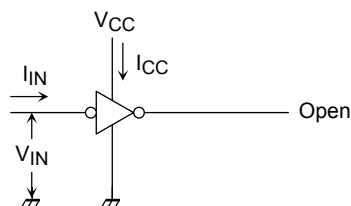
Characteristics		Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Output leakage current		I_{CEX}	1	$V_{CE} = 50\text{ V}$, $T_a = 25^\circ\text{C}$	—	—	50	μA
				$V_{CE} = 50\text{ V}$, $T_a = 85^\circ\text{C}$	—	—	100	
Output saturation voltage		$V_{CE(sat)}$	3	$I_{OUT} = 1.25\text{ A}$	—	—	1.8	V
				$I_{OUT} = 0.7\text{ A}$	—	—	1.3	
Input voltage	High level	V_{IH}	—	—	$V_{CC} - 1.6$	—	25	V
	Low level	V_{IL}	—	—	—	—	$V_{CC} - 3.6$	
Input current	High level	I_{IH}	—	—	—	—	10	μA
	Low level	I_{IL}	—	—	—	-0.05	-0.36	mA
Clamp diode reverse current		I_R	4	$V_R = 50\text{ V}$, $T_a = 25^\circ\text{C}$	—	—	50	μA
Clamp diode forward voltage		V_F	5	$I_F = 1.25\text{ A}$	—	1.5	2.0	V
Supply current	Output ON	$I_{CC(ON)}$	2	$V_{CC} = 5.5\text{ V}$, $V_{IN} = 0\text{ V}$	—	8.5	12.5	mA/ch
	Output OFF	$I_{CC(OFF)}$		$V_{CC} = 5.5\text{ V}$, $V_{IN} = V_{CC}$	—	—	1.0	μA
Turn-ON delay		t_{ON}	6	$C_L = 15\text{ pF}$, $V_{OUT} = 50\text{ V}$, $R_L = 40\ \Omega$	—	0.2	—	μs
Turn-OFF delay		t_{OFF}	6	$C_L = 15\text{ pF}$, $V_{OUT} = 35\text{ V}$, $R_L = 40\ \Omega$	—	5.0	—	μs

Test Circuit

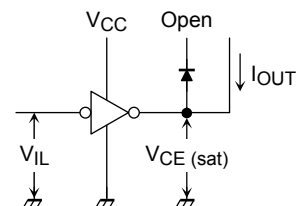
1. I_{CEX}



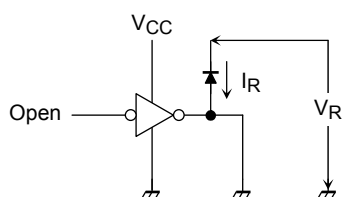
2. I_{CC}



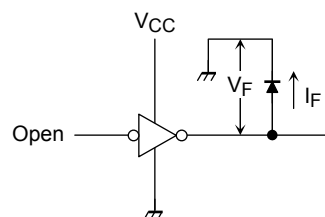
3. $V_{CE(sat)}$



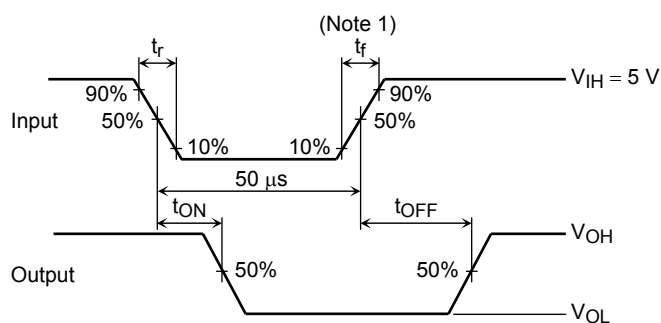
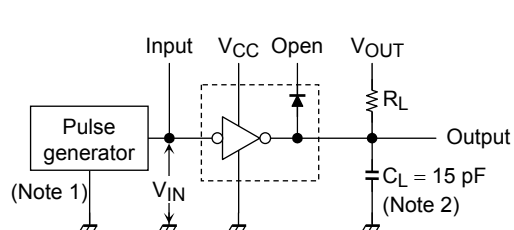
4. I_R



5. V_F

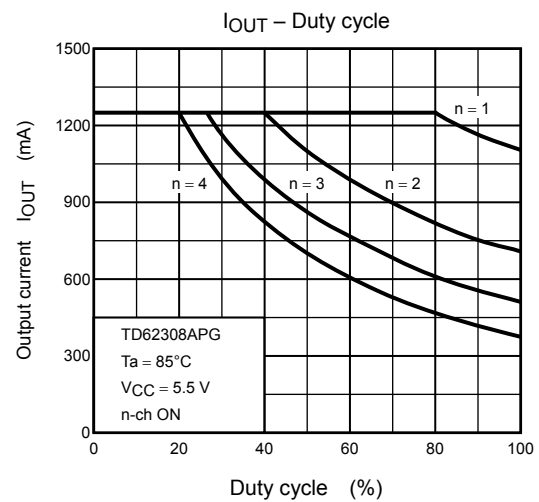
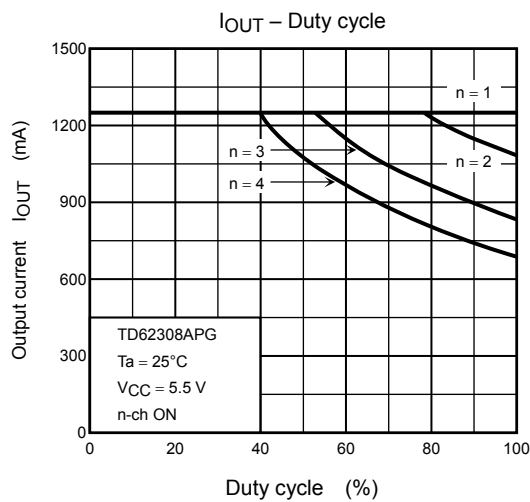
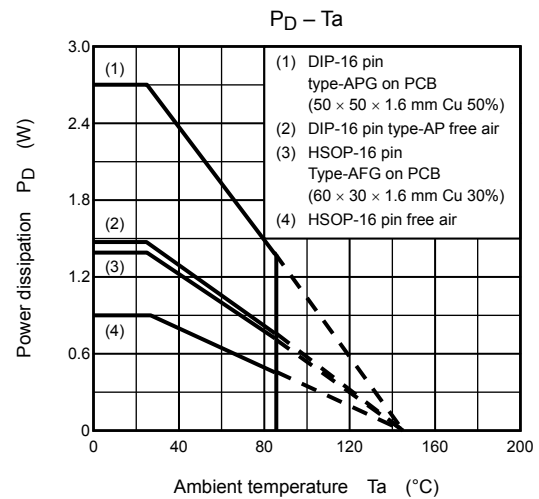
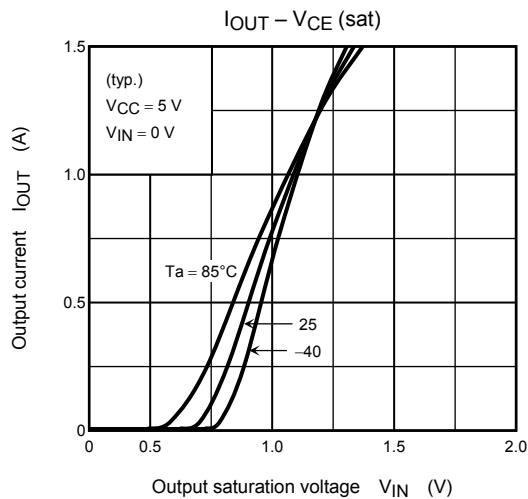
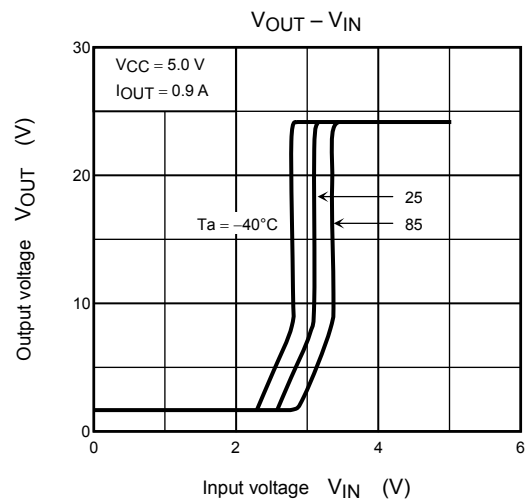
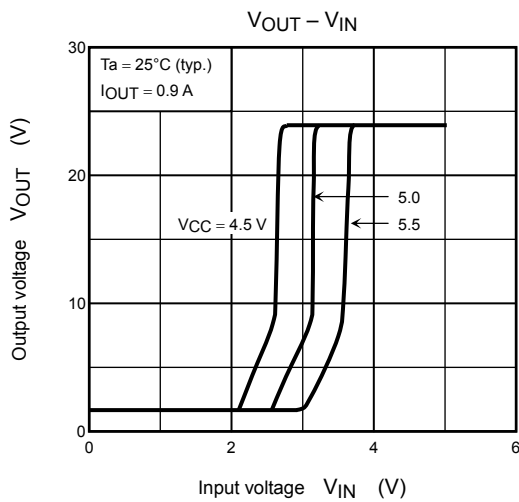


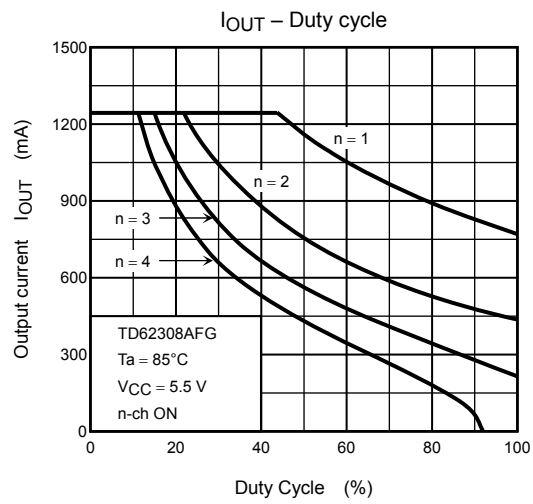
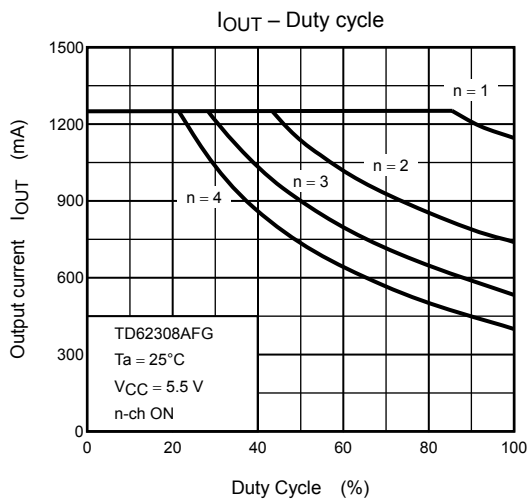
6. t_{ON} , t_{OFF}



Note 1: Pulse Width 50 μs , Duty Cycle 10%
Output Impedance 50 Ω , $t_r \leq 5\text{ ns}$, $t_f \leq 10\text{ ns}$

Note 2: C_L includes probe and jig capacitance

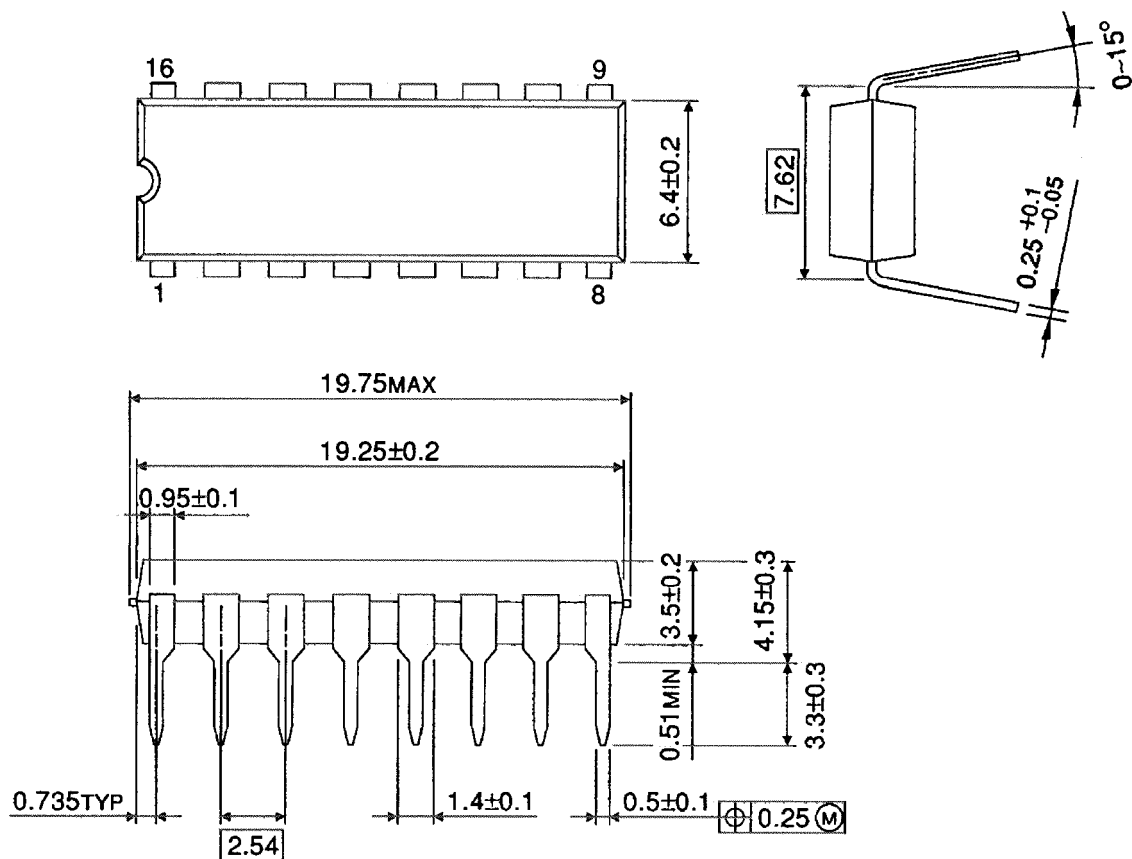




Package Dimensions

DIP16-P-300-2.54A

Unit : mm

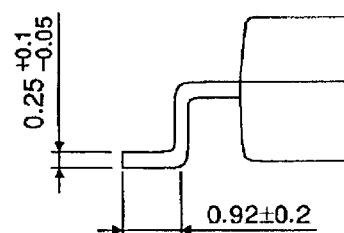
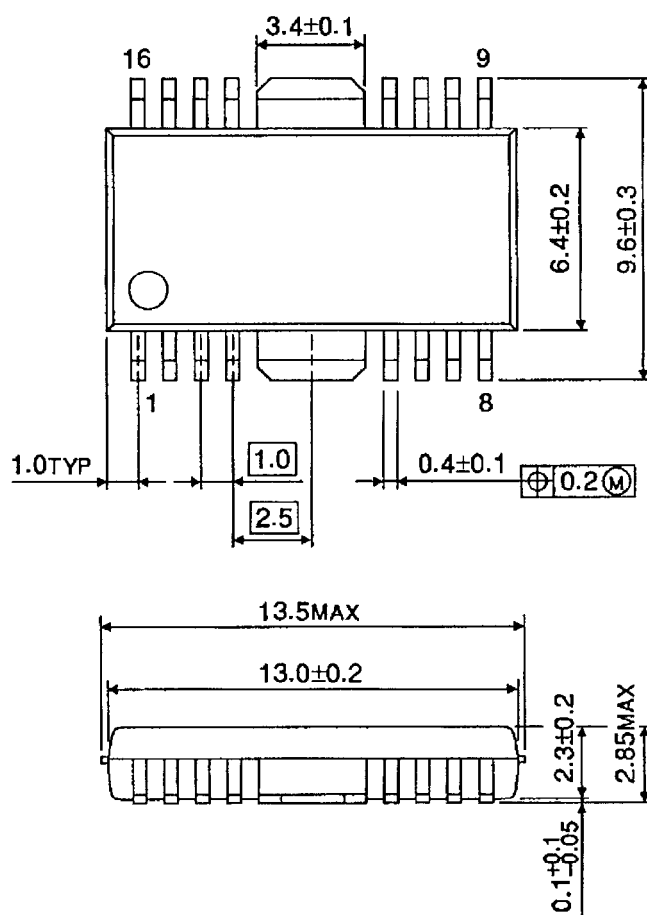


Weight: 1.11 g (typ.)

Package Dimensions

HSOP16-P-300-1.00

Unit : mm



Weight: 0.50 g (typ.)

Notes on Contents

1. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

2. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

IC Usage Considerations

Notes on Handling of ICs

- (1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.
Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly.
Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.
If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

Points to Remember on Handling of ICs**(1) Heat Radiation Design**

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (T_j) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into consideration the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flows back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond absolute maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

About solderability, following conditions were confirmed

- Solderability

(1) Use of Sn-37Pb solder Bath

- solder bath temperature = 230°C
- dipping time = 5 seconds
- the number of times = once
- use of R-type flux

(2) Use of Sn-3.0Ag-0.5Cu solder Bath

- solder bath temperature = 245°C
- dipping time = 5 seconds
- the number of times = once
- use of R-type flux

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